Search Notes

Application/Control No.

Applicant(s)/Patent under Reexamination
FUJITA ET AL.

10/653,242 Examiner

Art Unit

John S. Chu

1752

SEARCHED			
Class	Subclass	Date	Examiner
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430	183		
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430	186		
430	187		
534	560		

INTERFERENCE SEARCHED			
Class ·	Subclass	Date	Examiner
430	157,176		
430	183,184		
430	185,186		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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EAST SEARCH UPDATED	if  2006	ys
INVENTOR SEARCH		
STRUCTURE SEARCH UPDATED		

Search	Notes	(continued)

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